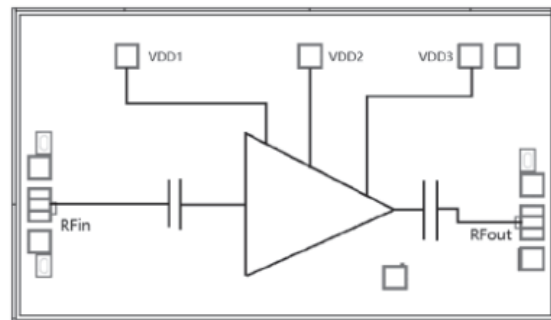


**Features**

- Frequency: 12-30GHz
- Gain: 15dB
- P1dB: +15.5dBm
- Power supply: +5.0V@86mA
- Die Size: 2190 x 1250  $\mu$ m

**Functional Block Diagram**

**Typical Applications**

- Test Instrumentation
- Microwave Radio & VSAT
- Military & Space
- Telecom Infrastructure
- Fiber Optics

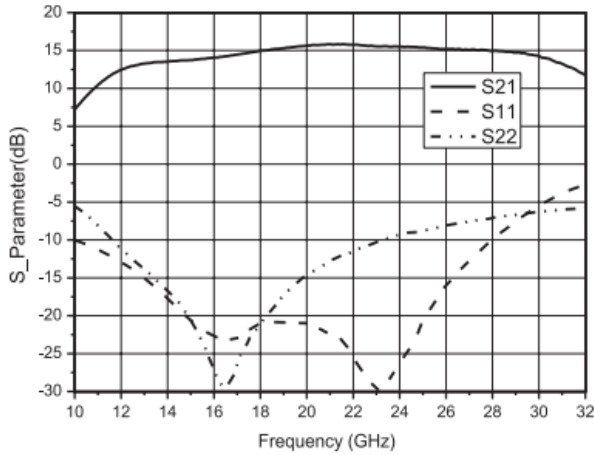
**Electrical Specifications**

TA = +25°C, Vdd = +5V

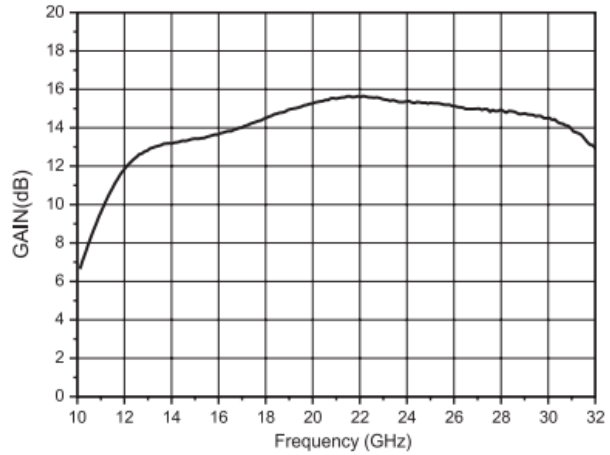
Parameters	Min.	Typ.	Max.	Units
Frequency		12-30		GHz
Gain		15		dB
P1dB		15.5		dBm
Input Return Loss		18		dB
Output Return Loss		14		dB
Operating Current		86		mA



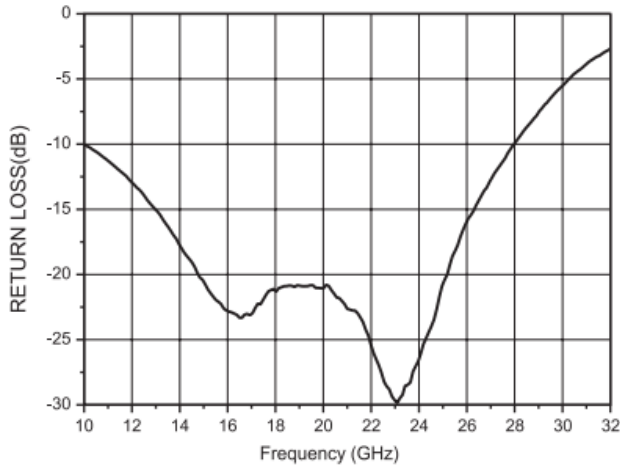
### S\_Parameter vs. Frequency



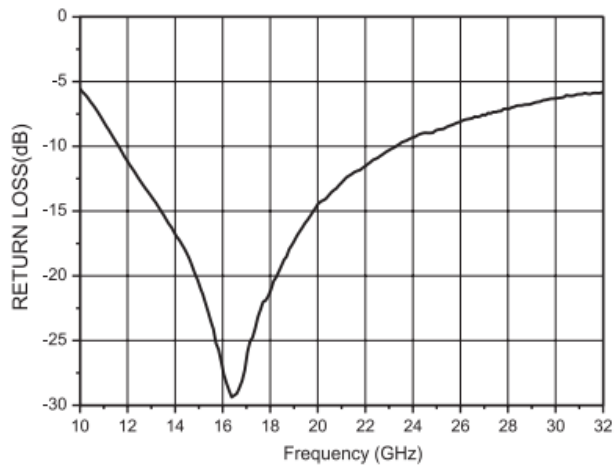
### Gain vs. Frequency



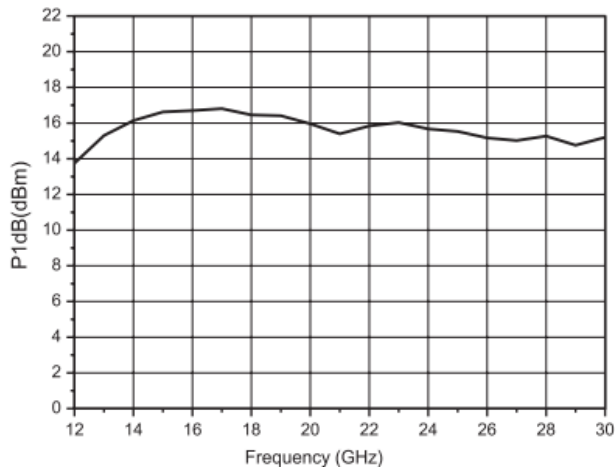
### Input Return Loss vs. Frequency



### Output Return Loss vs. Frequency

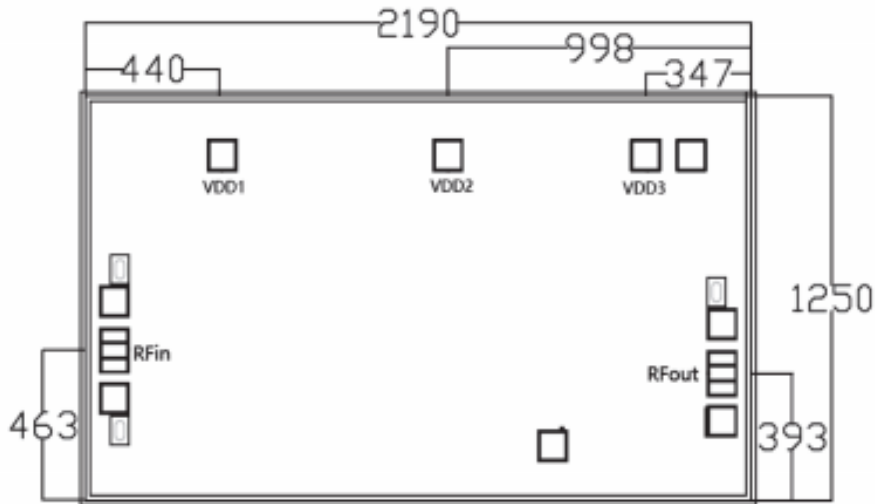


### P-1dB vs. Frequency





**Outline Drawing:**  
All Dimensions in um

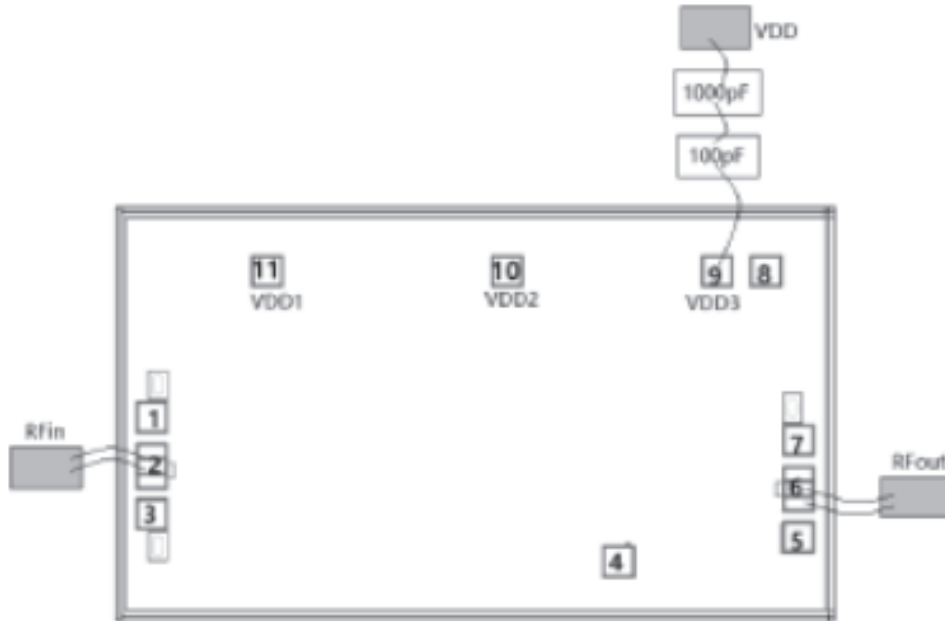


**Pad Description**

PAD	Function	Description
1,3,4,5,7,8	GND	Die bottom must be connected to RF/DC ground
2	RF IN	RF signal input terminal, external 50-ohm system required
6	RF OUT	RF signal output terminal, external 50-ohm system required
9,10,11	Vdd	Amplifier power supply, external 100pF capacitor required



### Assembly Drawing



#### Notes:

1. Die thickness: 100um
2. Typical bond pad is 100\*100  $\mu\text{m}^2$
3. Bond pad metalization: Gold
4. Backside metalization: Gold
5. Backside of the die (GND)
6. No connection required for unlabeled bond pads

#### Maximum Ratings:

1. Supply voltage: +5.5V
2. RF input power: +10dBm
3. Operating temperature: -55°C to +85°C
4. Storage temperature: -65°C to +150°C